

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MIWA, YASUHIRO	
		Examiner	Art Unit	Page 1 of 1
		Andrew Hwa S. Lee	2877	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,928,240	08-2005	Miwa, Yasuhiro	396/106
*	B	US-2004/0202462	10-2004	Miwa, Yasuhiro	396/106
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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